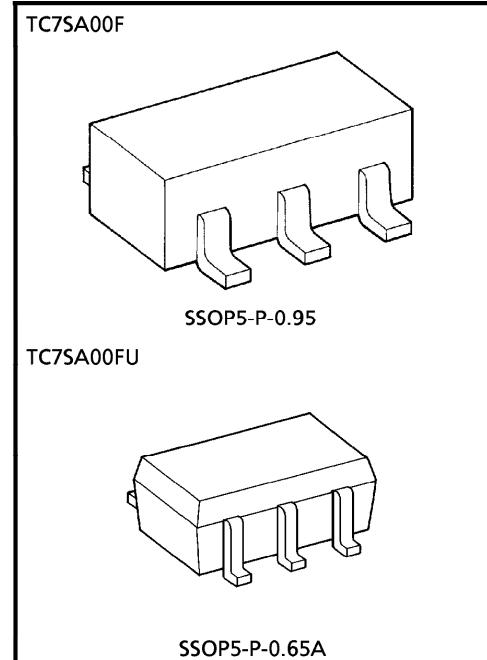


TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC7SA00F, TC7SA00FU**LOW-VOLTAGE 2-INPUT NAND GATE
WITH 3.6 V TOLERANT INPUTS AND OUTPUTS****FEATURES**

- Low Voltage Operation : $V_{CC} = 1.8\sim 3.6$ V
- High Speed Operation : $t_{pd} = 2.8$ ns (max.)
at $V_{CC} = 3.0\sim 3.6$ V
 $t_{pd} = 3.7$ ns (max.)
at $V_{CC} = 2.3\sim 2.7$ V
 $t_{pd} = 7.4$ ns (max.)
at $V_{CC} = 1.8$ V
- 3.6 V Tolerant inputs and outputs.
- Output Current : $I_{OH}/I_{OL} = \pm 24$ mA (min.)
at $V_{CC} = 3.0$ V
 $I_{OH}/I_{OL} = \pm 18$ mA (min.) at
 $V_{CC} = 2.3$ V
 $I_{OH}/I_{OL} = \pm 6$ mA (min.) at
 $V_{CC} = 1.8$ V
- Latch-up Performance : ± 300 mA
- ESD Performance : Human Body Model $> \pm 2000$ V
: Machine Model $> \pm 200$ V
- Power Down Protection is provided on all inputs and outputs.
- TC74VCX00FT Equivalent



Weight
SSOP5-P-0.95 : 0.016g (Typ.)
SSOP5-P-0.65A : 0.006g (Typ.)

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MAXIMUM RATINGS

PARAMETER	SYMBOL	RATING	UNIT
Power Supply Voltage	V_{CC}	- 0.5~4.6	V
DC Input Voltage	V_{IN}	- 0.5~4.6	V
DC Output Voltage	V_{OUT}	- 0.5~4.6 (Note 1)	V
		- 0.5~ V_{CC} + 0.5 (Note 2)	
Input Diode Current	I_{IK}	- 50	mA
Output Diode Current	I_{OK}	\pm 50 (Note 3)	mA
DC Output Current	I_{OUT}	\pm 50	mA
Power Dissipation	P_D	200	mW
DC V_{CC} / Ground Current	I_{CC} / I_{GND}	\pm 100	mA
Storage Temperature	T_{stg}	- 65~150	°C

(Note 1) : $V_{CC} = 0$ V(Note 2) : High or Low State. I_{OUT} absolute maximum rating must be observed.(Note 3) : $V_{OUT} < GND$, $V_{OUT} > V_{CC}$

RECOMMENDED OPERATING RANGE

PARAMETER	SYMBOL	RATING	UNIT
Supply Voltage	V_{CC}	1.8~3.6	V
		1.2~3.6 (Note 4)	
Input Voltage	V_{IN}	- 0.3~3.6	V
Output Voltage	V_{OUT}	0~3.6 (Note 5)	V
		0~ V_{CC} (Note 6)	
Output Current	I_{OH} / I_{OL}	\pm 24 (Note 7)	mA
		\pm 18 (Note 8)	
		\pm 6 (Note 9)	
Operating Temperature	T_{opr}	- 40~85	°C
Input Rise And Fall Time	dt/dv	0~10 (Note 10)	ns/V

(Note 4) : Data Retention Only

(Note 5) : $V_{CC} = 0$ V

(Note 6) : High or Low State

(Note 7) : $V_{CC} = 3.0$ ~3.6 V(Note 8) : $V_{CC} = 2.3$ ~2.7 V(Note 9) : $V_{CC} = 1.8$ V(Note 10) : $V_{IN} = 0.8$ ~2.0 V, $V_{CC} = 3.0$ V

ELECTRICAL CHARACTERISTICSDC characteristics ($T_a = -40\sim85^\circ C$, $2.7 V < V_{CC} \leq 3.6 V$)

PARAMETER		SYMBOL	TEST CONDITION		V_{CC} (V)	MIN.	MAX.	UNIT	
Input Voltage	"H" Level	V_{IH}				2.7~3.6	2.0	—	
	"L" Level	V_{IL}				2.7~3.6	—	0.8	
Output Voltage	"H" Level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu A$	2.7~3.6	$V_{CC} - 0.2$	—	V	
				$I_{OH} = -12 mA$	2.7	2.2	—		
				$I_{OH} = -18 mA$	3.0	2.4	—		
				$I_{OH} = -24 mA$	3.0	2.2	—		
	"L" Level	V_{OL}	$V_{IN} = V_{IH}$	$I_{OL} = 100 \mu A$	2.7~3.6	—	0.2	V	
				$I_{OL} = 12 mA$	2.7	—	0.4		
				$I_{OL} = 18 mA$	3.0	—	0.4		
				$I_{OL} = 24 mA$	3.0	—	0.55		
Input Leakage Current	I_{IN}	$V_{IN} = 0\sim3.6 V$			2.7~3.6	—	± 5.0	μA	
Power Off Leakage Current	I_{OFF}	$V_{IN}, V_{OUT} = 0\sim3.6 V$			0	—	10.0	μA	
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC}$ or GND		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 V$	2.7~3.6	—	20.0	μA	
Increase In I_{CC} Per Input	ΔI_{CC}	$V_{IH} = V_{CC} - 0.6 V$			2.7~3.6	—	750		

ELECTRICAL CHARACTERISTICSDC characteristics ($T_a = -40\sim85^\circ C$, $2.3 V \leq V_{CC} \leq 2.7 V$)

PARAMETER		SYMBOL	TEST CONDITION		V_{CC} (V)	MIN.	MAX.	UNIT	
Input Voltage	"H" Level	V_{IH}				2.3~2.7	1.6	—	
	"L" Level	V_{IL}				2.3~2.7	—	0.7	
Output Voltage	"H" Level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu A$	2.3~2.7	$V_{CC} - 0.2$	—	V	
				$I_{OH} = -6 mA$	2.3	2.0	—		
				$I_{OH} = -12 mA$	2.3	1.8	—		
				$I_{OH} = -18 mA$	2.3	1.7	—		
	"L" Level	V_{OL}	$V_{IN} = V_{IH}$	$I_{OL} = 100 \mu A$	2.3~2.7	—	0.2	V	
				$I_{OL} = 12 mA$	2.3	—	0.4		
				$I_{OL} = 18 mA$	2.3	—	0.6		
				$I_{OL} = 24 mA$	2.3	—	0.8		
Input Leakage Current	I_{IN}	$V_{IN} = 0\sim3.6 V$			2.3~2.7	—	± 5.0	μA	
Power Off Leakage Current	I_{OFF}	$V_{IN}, V_{OUT} = 0\sim3.6 V$			0	—	10.0	μA	
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC}$ or GND		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 V$	2.3~2.7	—	20.0	μA	
		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 V$			2.3~2.7	—	± 20.0		

ELECTRICAL CHARACTERISTICSDC characteristics ($T_a = -40\sim85^\circ C$, $1.8 V \leq V_{CC} < 2.3 V$)

PARAMETER		SYMBOL	TEST CONDITION		V_{CC} (V)	MIN.	MAX.	UNIT	
Input Voltage	"H" Level	V_{IH}				1.8~2.3	$0.7 \times V_{CC}$	—	
	"L" Level	V_{IL}				1.8~2.3	—	$0.2 \times V_{CC}$	
Output Voltage	"H" Level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu A$	1.8	$V_{CC} - 0.2$	—	V	
	"L" Level	V_{OL}		$I_{OL} = 100 \mu A$	1.8	1.4	—		
Input Leakage Current	I_{IN}	$V_{IN} = 0\sim3.6 V$		$I_{OL} = 6 mA$	1.8	—	0.2	μA	
Power Off Leakage Current	I_{OFF}	$V_{IN}, V_{OUT} = 0\sim3.6 V$			1.8	—	0.3		
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC}$ or GND		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 V$	1.8	—	20.0	μA	
					1.8	—	± 20.0		

AC characteristics ($T_a = -40\sim85^\circ C$, Input $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500 \Omega$)

PARAMETER		SYMBOL	TEST CONDITION		V_{CC} (V)	MIN.	MAX.	UNIT	
Propagation Delay Time		t_{pLH} t_{pHL}	(Fig.1, 2)			1.8	1.5	7.4	
						2.5 ± 0.2	1.0	3.7	
						3.3 ± 0.3	0.8	2.8	

For $C_L = 50$ pF, add approximately 300 ps to the AC maximum specification.Dynamic switching characteristics ($T_a = 25^\circ C$, Input $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

PARAMETER		SYMBOL	TEST CONDITION		V_{CC} (V)	TYP.	UNIT	
Quiet Output Maximum Dynamic V_{OL}		V_{OLP}	$V_{IH} = 1.8 V, V_{IL} = 0 V$ (Note 11)			1.8	0.25	
			$V_{IH} = 2.5 V, V_{IL} = 0 V$ (Note 11)			2.5	0.6	
			$V_{IH} = 3.3 V, V_{IL} = 0 V$ (Note 11)			3.3	0.8	
Quiet Output Minimum Dynamic V_{OL}		V_{OLV}	$V_{IH} = 1.8 V, V_{IL} = 0 V$ (Note 11)		1.8	-0.25	V	
			$V_{IH} = 2.5 V, V_{IL} = 0 V$ (Note 11)			2.5	-0.6	
			$V_{IH} = 3.3 V, V_{IL} = 0 V$ (Note 11)			3.3	-0.8	
Quiet Output Minimum Dynamic V_{OH}		V_{OHV}	$V_{IH} = 1.8 V, V_{IL} = 0 V$ (Note 11)		1.8	1.5	V	
			$V_{IH} = 2.5 V, V_{IL} = 0 V$ (Note 11)			2.5	1.9	
			$V_{IH} = 3.3 V, V_{IL} = 0 V$ (Note 11)			3.3	2.2	

(Note 11) : Parameter guaranteed by design.

Capacitive characteristics ($T_a = 25^\circ\text{C}$)

PARAMETER	SYMBOL	TEST CONDITION	V _{CC} (V)	TYP.	UNIT
			1.8, 2.5, 3.3		
Input Capacitance	C _{IN}	—	1.8, 2.5, 3.3	6	pF
Power Dissipation Capacitance	C _{PD}	f _{IN} = 10 MHz (Note 12)	1.8, 2.5, 3.3	20	pF

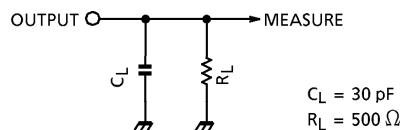
(Note 12) : C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

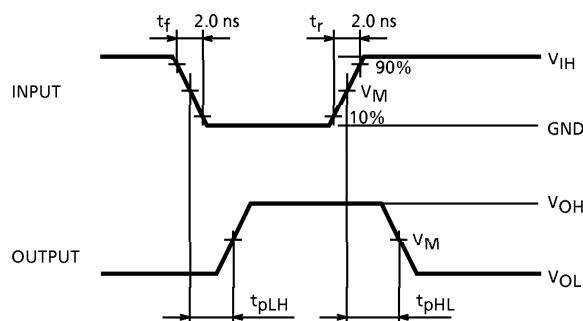
$$I_{CC}(\text{opr.}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

TEST CIRCUIT

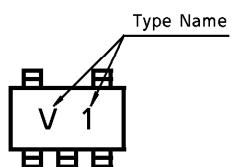
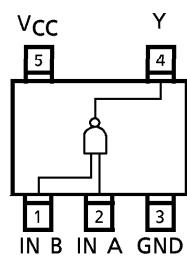
Fig.1



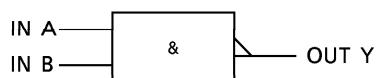
AC WAVEFORM

Fig.2 t_{pLH}, t_{pHL}

SYMBOL	V _{CC}		
	3.3 ± 0.3 V	2.5 ± 0.2 V	1.8 V
V _{IH}	2.7 V	V _{CC}	V _{CC}
V _M	1.5 V	V _{CC} /2	V _{CC} /2

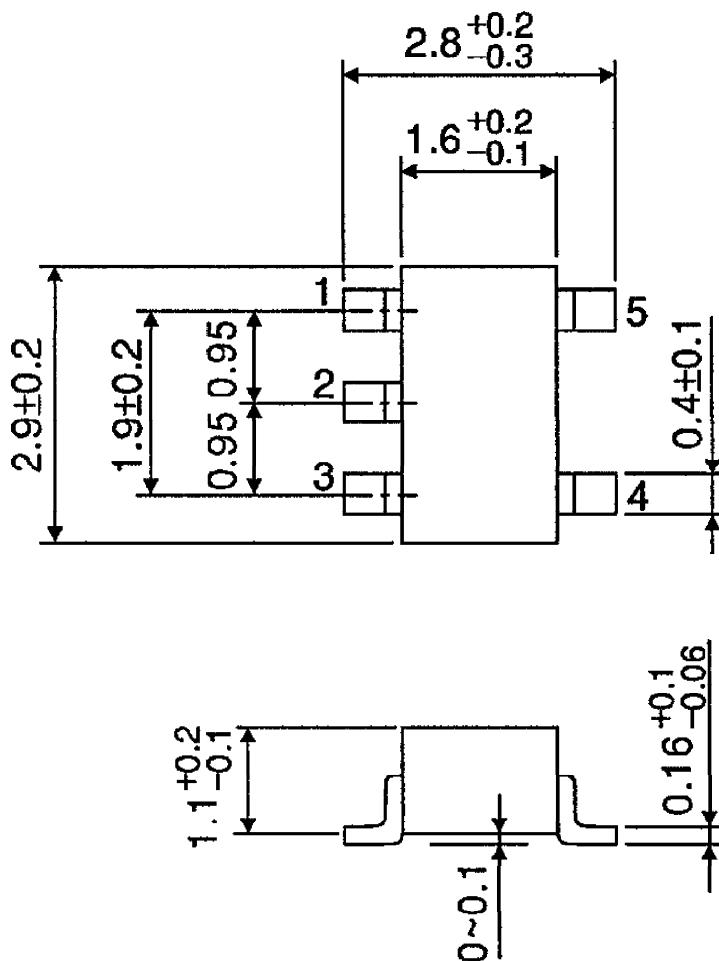
MARKING**PIN ASSIGNMENT (TOP VIEW)****TRUTH TABLE**

INPUTS		OUTPUTS
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

LOGIC DIAGRAM

PACKAGE DIMENSIONS
SSOP5-P-0.95

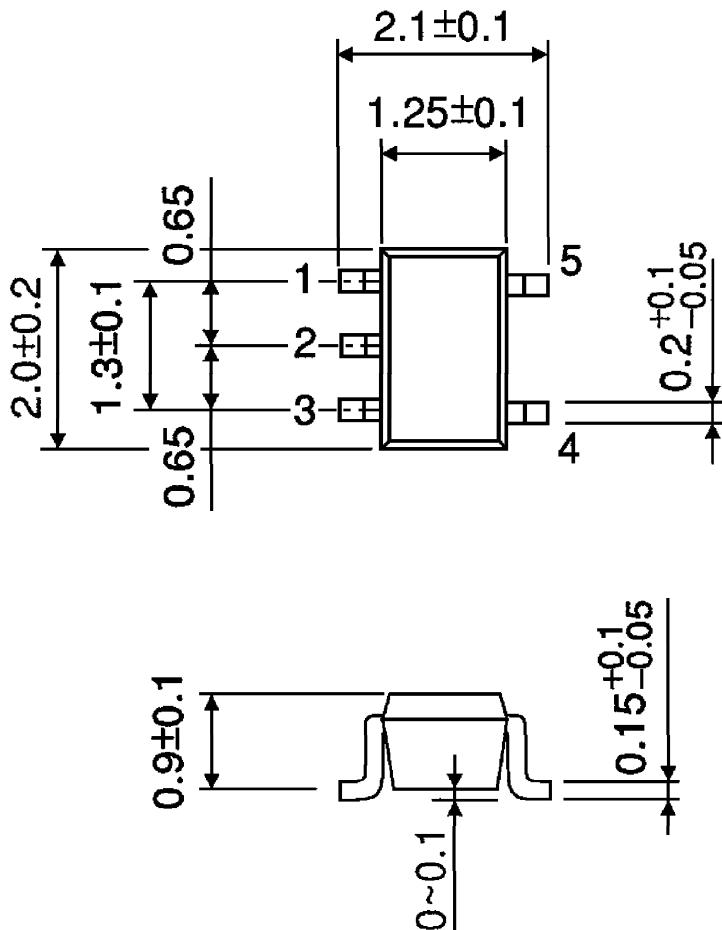
Unit : mm



Weight : 0.016 g (Typ.)

PACKAGE DIMENSIONS
SSOP5-P-0.65A

Unit : mm



Weight : 0.006 g (Typ.)